

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/725,522 | | Applicant(s)/Patent Under Reexamination MURAYAMA ET AL. | |
| | Examiner Gary D. Harris | | Art Unit 1773 | Page 1 of 4 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-4,596,747 A | 06-1986 | Nishimatsu et al. | 428/840.5 |
| * | B | US-4,603,081 A | 07-1986 | Shimada et al. | 428/336 |
| * | C | US-4,601,947 A | 07-1986 | Shimada et al. | 428/336 |
| * | D | US-4,637,963 A | 01-1987 | Nishimatsu et al. | 428/840.5 |
| * | E | US-4,671,995 A | 06-1987 | Sekiya et al. | 428/840.5 |
| * | F | US-4,678,708 A | 07-1987 | Shimada et al. | 428/336 |
| * | G | US-4,689,269 A | 08-1987 | Mukai et al. | 428/413 |
| * | H | US-4,702,959 A | 10-1987 | Shimozawa et al. | 428/323 |
| * | I | US-4,746,558 A | 05-1988 | Shimozawa et al. | 428/141 |
| * | J | US-4,780,354 A | 10-1988 | Nakayama et al. | 428/141 |
| * | K | US-4,795,672 A | 01-1989 | Takeda et al. | 428/216 |
| * | L | US-4,801,392 A | 01-1989 | Adair et al. | 252/62.54 |
| * | M | US-4,842,942 A | 06-1989 | Yatsuka et al. | 428/425.9 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|---------------|----------------|
| * | N | JP 09115130 A | 05-1997 | Japan | TAKANO et al. | G11B 05/70 |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/725,522 | Applicant(s)/Patent Under Reexamination MURAYAMA ET AL. | |
| | Examiner Gary D. Harris | Art Unit 1773 | Page 2 of 4 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| * | A | US-4,848,348 A | 07-1989 | Craighead, Lawrence W. | 600/396 |
| * | B | US-4,933,221 A | 06-1990 | Nishimura et al. | 428/64.9 |
| * | C | US-4,975,322 A | 12-1990 | Hideyama et al. | 428/323 |
| * | D | US-5,712,028 A | 01-1998 | Seki et al. | 428/216 |
| * | E | US-6,074,724 A | 06-2000 | Inaba et al. | 428/141 |
| * | F | US-6,331,342 B1 | 12-2001 | Inoue, Satoru | 428/141 |
| * | G | US-2003/0096139 A1 | 05-2003 | Murayama et al. | 428/694.0BC |
| * | H | US-6,610,426 B2 | 08-2003 | Hashimoto et al. | 428/844.6 |
| * | I | US-2003/0180578 A1 | 09-2003 | Hayakawa et al. | 428/694.0TS |
| * | J | US-6,632,548 B2 | 10-2003 | Saito et al. | 428/841 |
| * | K | US-6,645,648 B2 | 11-2003 | Doushita et al. | 428/845.5 |
| * | L | US-2004/0110038 A1 | 06-2004 | Murayama et al. | 428/694.0BN |
| * | M | US-6,759,150 B2 | 07-2004 | Suzuki et al. | 428/844.8 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/725,522 | | Applicant(s)/Patent Under Reexamination MURAYAMA ET AL. | |
| | Examiner Gary D. Harris | | Art Unit 1773 | Page 3 of 4 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,767,613 B2 | 07-2004 | Murayama et al. | 428/840.5 |
| * | B | US-6,777,061 B2 | 08-2004 | Kitamura et al. | 428/840.2 |
| * | C | US-6,773,789 B2 | 08-2004 | Murayama et al. | 428/840.5 |
| * | D | US-2004/0191465 A1 | 09-2004 | Murayama et al. | 428/065.5 |
| * | E | US-2004/0197603 A1 | 10-2004 | Hashimoto et al. | 428/694.0BC |
| * | F | US-6,821,602 B2 | 11-2004 | Kurose et al. | 428/840.3 |
| * | G | US-2005/0089721 A1 | 04-2005 | Murayama et al. | 428/694.0BC |
| * | H | US-2005/0106420 A1 | 05-2005 | Kurose et al. | 428/694.0BR |
| * | I | US-2005/0112410 A1 | 05-2005 | Mori et al. | 428/694.0BU |
| * | J | US-2005/0112409 A1 | 05-2005 | Murayama et al. | 428/694.0BA |
| * | K | US-6,936,328 B2 | 08-2005 | Hayakawa et al. | 428/141 |
| * | L | US-6,939,606 B2 | 09-2005 | Hashimoto et al. | 428/840.2 |
| * | M | US-2006/0008681 A1 | 01-2006 | Hashimoto et al. | 428/840.2 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/725,522 | | Applicant(s)/Patent Under Reexamination MURAYAMA ET AL. | |
| | Examiner Gary D. Harris | | Art Unit 1773 | Page 4 of 4 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-2006/0024515 A1 | 02-2006 | Murayama et al. | 428/458 |
| * | B | US-2006/0068233 A1 | 03-2006 | Murayama et al. | 428/844.7 |
| * | C | US-2006/0083953 A1 | 04-2006 | Murayama et al. | 428/844.8 |
| * | D | US-2006/0194081 A1 | 08-2006 | Murayama et al. | 428/844.6 |
| * | E | US-2006/0228590 A1 | 10-2006 | Hashimoto et al. | 428/840.5 |
| * | F | US-2007/0059563 A1 | 03-2007 | Hashimoto et al. | 428/840.5 |
| * | G | US-7,208,237 B2 | 04-2007 | Seki et al. | 428/842.3 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.